

Search Notes

Application/Control No.

10/712,923

Examiner

Toan Ton

Applicant(s)/Patent under
Reexamination

IWASA ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	113,110	3/15/2005	TTON
	137		
	44		
313	503		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST liquid crystal reflect\$ anti reflect\$ black mask/matrix light shield\$5/block\$ silicon ti tin al, mo, cr oxynitride,oxn	3/15/2005	TTON